

**Notice of References Cited**Application/Control  
09/709,203Applicant(s)/Patent Under  
Reexamination  
NAKANO ET AL.Examiner  
Dung X NguyenArt Unit  
2631

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,643,820	11-2003	Tomita, Tsuyoshi	714/798
	B	US-6,603,829	08-2003	Glaser et al.	375/360
	C	US-6,526,106	02-2003	Migita, Takahisa	375/354
	D	US-6,442,703	08-2002	Nakamura, Satoshi	713/500
	E	US-6,078,576	06-2000	Schilling et al.	370/347
	F	US-6,163,585	12-2000	Yamawaki et al.	375/373
	G	US-5,987,078	11-1999	Kiyanagi et al.	375/344
	H	US-5,930,697	07-1999	Bohme et al.	455/315
	I	US-5,886,946	03-1999	Ooishi, Tsukasa	365/233
	J	US-5,644,606	07-1997	Martinez et al.	375/376
	K	US-5,455,840	10-1995	Nakauchi et al.	375/371
	L	US-5,353,069	10-1994	Kobo et al.	348/611
	M	US-5,056,121	10-1991	Ohta et al.	375/118

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	4-96535's Translation	03-1992	Japan	Oseki, Sumio	H04L 7/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

T